

Resource Summary Report

Generated by [RRID](#) on Aug 6, 2026

Gatan: Dimple Grinder II Transmission Electron Microscope (TEM) Specimen Preparation

RRID:SCR_019928

Type: Tool

Proper Citation

Gatan: Dimple Grinder II Transmission Electron Microscope (TEM) Specimen Preparation (RRID:SCR_019928)

Resource Information

URL: <https://www.gatan.com/products/tem-specimen-preparation/dimple-grinder-ii>

Proper Citation: Gatan: Dimple Grinder II Transmission Electron Microscope (TEM) Specimen Preparation (RRID:SCR_019928)

Description: Instrument that prepares TEM specimens with mechanical method of pre-thinning to near electron transparency to greatly reduce ion milling times and uneven thinning.

Resource Type: instrument resource

Keywords: Gatan, Transmission Electron Microscope, grinder, Instrument Equipment, USEDit

Availability: Commercially available

Specification URL: https://raw.githubusercontent.com/SciCrunch/RRID-Instruments/main/PDF/SCR_019928.pdf

Resource Name: Gatan: Dimple Grinder II Transmission Electron Microscope (TEM) Specimen Preparation

Resource ID: SCR_019928

Alternate IDs: Model_Number_Dimple_Grinder_II

Record Creation Time: 20220129T080347+0000

Record Last Update: 20260801T190648+0000

Ratings and Alerts

No rating or validation information has been found for Gatan: Dimple Grinder II Transmission Electron Microscope (TEM) Specimen Preparation.

No alerts have been found for Gatan: Dimple Grinder II Transmission Electron Microscope (TEM) Specimen Preparation.

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.